

<b>Notice of References Cited</b>	Application/Control No. 10/568,621		Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner TODD D. JACOBS		Art Unit 4159	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,755,624	06-2004	Bae et al.	417/221
*	B	US-6,132,177	10-2000	Loprete et al.	417/221
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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